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A terphenyl halide series: 2,6-Trip₂-H₃C₆X (Trip = 2,4,6-triisopropylphenyl; X = Cl, Br, I)

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The sterically encumbered terphenyl halides 2'-chloro-2,2",4,4",6,6"-hexaisopropyl-1,1':3',1"-terphenyl, $C_{36}H_{49}Cl$, (I), 2'-bromo-2,2",4,4",6,6"-hexaisopropyl-1,1':3',1"-terphenyl, $C_{36}H_{49}Br$, (II), and 2'-iodo-2,2",4,4",6,6"-hexaisopropyl-1,1':3',1"-terphenyl, $C_{36}H_{49}I$, (III), crystallize in space group *Pnma*. They are isomorphous and isostructural with a plane of symmetry through the centre of the molecule. The C-halide bond distances are 1.745 (3), 1.910 (4) and 2.102 (6) Å for (I)–(III), respectively.

Comment

Terphenyl halides are useful starting materials for the synthesis of a wide variety of compounds with unusual coordination numbers and bonding (Twamley *et al.*, 1999). The synthesis of these materials is a relatively straightforward process (Harada *et al.*, 1985; Saednya & Hart, 1996; Frank Du *et al.*, 1986; Schiemenz & Power, 1996; Simons *et al.*, 1998) involving the addition of two equivalents of aryl Grignard reagent to 1-lithio-2,6-dichlorobenzene at 195 K and subsequent quenching with the appropriate dihalide. Using this technique, good yields (>80%) of 2,6-Trip₂-C₆H₃X (Trip = 2,4,6-triiso-propylphenyl; X = Cl, Br, I) can be obtained. All are highmelting solids (m.p. > 453 K) and can be crystallized easily from hydrocarbon solvents such as hexanes, giving colourless needles.

Compounds (I)–(III) form isomorphous crystals and are isostructural. They crystallize in the orthorhombic space group *Pnma*, with very similar cell constants. Each molecule has a plane of symmetry through the halide atom and the central ring with C1, C4 and the halide atom occupying special positions. The aromatic rings show normal C–C bond lengths and C–C–C angles. The pendant aromatic C–C bond to the central ring [1.491 (5)–1.500 (3) Å] shows a slight elongation commonly observed in terphenyl groups as a result of steric

effects. The C-X distances range from 1.745 (3) Å in the chloride, (I), to 1.910 (4) Å in the bromide, (II), and 2.102 (6) Å in the iodide, (III). These bond lengths are almost identical to those found in the few structurally characterized



terphenyl halides. Previously reported C–Br bond lengths are 1.892 (5) (Haaland *et al.*, 1994), 1.887 (9) (Allman & Hellner, 1968) and 1.90 (2) Å. The latter refers to the isostructural perfluorinated terphenyl bromide 2,6-(C₆F₅)₂-C₆F₃Br (Bowen Jones & Brown, 1980). The less crowded 2,6-Mes₂C₆H₃I (Mes = 2,4,6-trimethylphenyl) has a reported C–I distance of 2.122 (4) Å (Niemeyer, 1998), and the polychlorinated terphenyl iodide ArICl₂ [Ar = 2,6-bis(3,5-dichloro-2,4,6-trimethylphenyl)benzene] has a C–I distance of 2.127 (13) Å (Protasiewicz, 1995). Although no *m*-terphenyl chlorides have been structurally characterized, the C–Cl distance falls within normal aromatic chloride distances (1.673–1.785 Å).

Experimental

Compounds (I)-(III) were synthesized according to the published method for the iodine derivative of Schiemenz & Power (1998) with quenching by the appropriate halide. This route may be illustrated by the synthesis of the bromide derivative, (II). Triisopropylphenylbromide (59.79 g, 0.211 mol) was reacted with Mg (5.20 g, 0.220 mol) in tetrahydrofuran (THF) to form the Grignard reagent. A solution of n-BuLi in hexanes (56.1 ml of a 1.6 M) was added to 1,3-dichlorobenzene (13.20 g, 0.090 mol) in THF at 195 K. This solution was stirred for 30 min and the above Grignard reagent added dropwise via cannula. The reaction mixture was gradually warmed to room temperature overnight. Br₂ (6.62 ml, 0.130 mol) was added via syringe at 273 K. The mixture was stirred (2 h) and then washed with 200 ml of a saturated Na₂CO₃ solution. The organic phase was separated and the aqueous phase extracted with 150 ml of diethyl ether. The combined organic phase was dried over MgSO₄, filtered and the solvent removed. The yellow solid was distilled at 0.1 mm Hg and 383 K to remove side products (TripBr). The solid was refluxed in ethanol for 3 h. The product was filtered and washed with 50 ml of cold acetone and recrystallized from hexanes. [Yield 36.45 g (72.3%); m.p. 484-486 K.] (I): ¹H NMR (C₆D₆, 300 MHz) δ 1.20 [d, 12H, o- $CH(CH_3)_2$, ${}^{3}J_{HH} = 6.9 Hz$], 1.24 [*d*, 12H, *o*-CH(CH₃)₂, ${}^{3}J_{HH} = 6.9 Hz$], 1.35 [d, 12H, p-CH(CH₃)₂, ${}^{3}J_{HH} = 6.6$ Hz], 2.85 (sept, 3H, o,p-CH, ${}^{3}J_{\text{HH}} = 6.9 \text{ Hz}$, 6.97 (t, 1H, p-C₆H₃, ${}^{3}J_{\text{HH}} = 6.6 \text{ Hz}$), 7.07, (d, 2H, m- C_6H_3 , ${}^{3}J_{HH} = 7.35$ Hz), 7.23 (s, 4H, *m*-Trip). ${}^{13}C$ { ^{1}H } NMR (C_6D_6 , 75 MHz) δ 24.3, 24.5, 24.9, 31.6, 34.9, 121.1 (*m*-Trip), 126.4 (*p*-C₆H₃), 130.5 (*m*-C₆H₃), 135.1 (*o*-C₆H₃), 135.7 (*ipso*-C₆H₃), 140.8 (*i*-Trip), 146.6 (*o*-Trip), 148.9 (*p*-Trip). (II): ¹H NMR (CDCl₃, 300 MHz) δ 1.12 $[d, 12H, o-CH(CH_3)_2, {}^{3}J_{HH} = 6.9 \text{ Hz}], 1.18 [d, 12H, o-CH(CH_3)_2, {}^{3}J_{HH}$ = 6.9 Hz], 1.33 [d, 12H, p-CH(CH₃)₂, ${}^{3}J_{HH}$ = 6.9 Hz], 2.58 (sept, 2H, o-CH, ${}^{3}J_{\text{HH}} = 6.9 \text{ Hz}$), 2.97 (*sept*, 1H, *p*-CH, ${}^{3}J_{\text{HH}} = 6.9 \text{ Hz}$), 7.08 (*s*, 4H,

 $m\text{-}\mathrm{Trip}),~7.19~(d,~2\mathrm{H},~m\text{-}\mathrm{C}_{6}\mathrm{H}_{3},~^{3}J_{\mathrm{HH}}=7.5~\mathrm{Hz}),~7.38~(t,~1\mathrm{H},~p\text{-}\mathrm{C}_{6}\mathrm{H}_{3},~^{3}J_{\mathrm{HH}}=6.9~\mathrm{Hz}).~^{13}\mathrm{C}~[^{1}\mathrm{H}]~\mathrm{NMR}~(\mathrm{CDCl}_{3},~75~\mathrm{MHz})~\delta~23.6,~24.1,~24.7,~30.9,~34.2,~120.6~(m\text{-}\mathrm{Trip}),~126.4~(p\text{-}\mathrm{C}_{6}\mathrm{H}_{3}),~128.3~(ipso\text{-}\mathrm{C}_{6}\mathrm{H}_{3}),~129.6~(m\text{-}\mathrm{C}_{6}\mathrm{H}_{3}),~136.4~(o\text{-}\mathrm{C}_{6}\mathrm{H}_{3}),~142.2~(i\text{-}\mathrm{Trip}),~145.8~(o\text{-}\mathrm{Trip}),~148.1~(p\text{-}\mathrm{Trip}).$

Compound (I)

Crystal data

 $\begin{array}{l} C_{36}H_{49}Cl \\ M_r = 517.20 \\ \text{Orthorhombic, $Pnma$} \\ a = 8.2186 (5) \text{ Å} \\ b = 25.4368 (16) \text{ Å} \\ c = 15.6604 (10) \text{ Å} \\ V = 3273.9 (4) \text{ Å}^3 \\ Z = 4 \\ D_x = 1.049 \text{ Mg m}^{-3} \end{array}$

Data collection

Bruker SMART 1000 diffractometer ω scans Absorption correction: empirical (*SADABS*; Sheldrick 1999) $T_{min} = 0.957$, $T_{max} = 0.995$ 47 039 measured reflections 3852 independent reflections 2275 reflections with $I > 2\sigma(I)$

Refinement

Refinement on F^2 $R[F^2 > 2\sigma(F^2)] = 0.047$ $wR(F^2) = 0.128$ S = 0.9123852 reflections 172 parameters

Compound (II)

Crystal data $C_{36}H_{49}Br$ $M_r = 561.66$ Orthorhombic, *Pnma* a = 8.2823 (14) Å b = 25.831 (4) Å c = 15.856 (3) Å $V = 3392.2 (10) Å^3$ Z = 4 $D_x = 1.100 Mg m^{-3}$

Data collection

Siemens SMART 1000 diffractometer ω scans Absorption correction: empirical (*SADABS*; Sheldrick, 1999) $T_{min} = 0.447$, $T_{max} = 0.791$ 23 472 measured reflections 3054 independent reflections 2418 reflections with $I > 2\sigma(I)$

Refinement

Refinement on F^2 $R[F^2 > 2\sigma(F^2)] = 0.044$ $wR(F^2) = 0.114$ S = 1.0233054 reflections 178 parameters H-atom parameters constrained Mo K α radiation Cell parameters from 4302 reflections $\theta = 2.60-31.42^{\circ}$ $\mu = 0.137 \text{ mm}^{-1}$ T = 93 (2) K Needle, colourless $0.32 \times 0.15 \times 0.04 \text{ mm}$

$$\begin{split} R_{\rm int} &= 0.134 \\ \theta_{\rm max} &= 27.49^{\circ} \\ h &= 0 \rightarrow 10 \\ k &= 0 \rightarrow 33 \\ l &= 0 \rightarrow 20 \\ \text{50 frames remeasured standard reflections} \\ \text{beginning and end reflections} \\ \text{intensity decay: } <0.01\% \end{split}$$

H-atom parameters constrained $w = 1/[\sigma^2(F_o^2) + (0.0660P)^2]$ where $P = (F_o^2 + 2F_c^2)/3$ $(\Delta/\sigma)_{max} = 0.001$ $\Delta\rho_{max} = 0.55 \text{ e } \text{\AA}^{-3}$ $\Delta\rho_{min} = -0.42 \text{ e } \text{\AA}^{-3}$

Mo K α radiation Cell parameters from 934 reflections $\theta = 2.88-24.64^{\circ}$ $\mu = 1.232 \text{ mm}^{-1}$ T = 293 (2) K Needle, colourless $0.78 \times 0.30 \times 0.20 \text{ mm}$

 $R_{int} = 0.033$ $\theta_{max} = 25.00^{\circ}$ $h = -9 \rightarrow 9$ $k = -25 \rightarrow 30$ $l = -18 \rightarrow 18$ 50 frames remeasured standard reflections beginning and end reflections intensity decay: <0.01%

$$\begin{split} &w = 1/[\sigma^2(F_o^2) + (0.0522P)^2 \\ &+ 2.2426P] \\ &where \ P = (F_o^2 + 2F_c^2)/3 \\ (\Delta/\sigma)_{\max} < 0.001 \\ \Delta\rho_{\max} = 0.26 \ e \ {\rm \AA}^{-3} \\ \Delta\rho_{\min} = -0.40 \ e \ {\rm \AA}^{-3} \end{split}$$

Compound (III)

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Crystal data
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C36H49I
M_r = 608.65
Orthorhombic, Pnma
a = 8.1100 (13) \text{ Å}
b = 25.549 (6) Å
c = 15.978 (6) Å
V = 3310.7 (16) \text{ Å}^3
Z = 4
D_x = 1.221 \text{ Mg m}^{-3}
Data collection
Siemens R3 diffractometer
\omega scans
Absorption correction: empirical
   (XABS2; Parkin et al., 1995)
   T_{\min} = 0.521, \ T_{\max} = 0.756
8539 measured reflections
3891 independent reflections
3185 reflections with I > 2\sigma(I)
Refinement
```

Refinement on F^2 $R[F^2 > 2\sigma(F^2)] = 0.059$ $wR(F^2) = 0.186$ S = 1.0443891 reflections 172 parameters H-atom parameters constrained reflections $\theta = 4.73-14.73^{\circ}$ $\mu = 0.988 \text{ mm}^{-1}$ T = 130 (2) KParallelepiped, colourless $0.76 \times 0.36 \times 0.30 \text{ mm}$ $R_{\text{int}} = 0.0452$ $\theta_{\text{max}} = 27.5^{\circ}$ $h = 0 \rightarrow 10$ $k = 0 \rightarrow 33$ $l = 0 \rightarrow 20$ 2 standard reflections every 198 reflections intensity decay: 1%

Mo $K\alpha$ radiation

Cell parameters from 50

$$\begin{split} &w = 1/[\sigma^2(F_o^2) + (0.1110P)^2 \\ &+ 10.4168P] \\ &where \ P = (F_o^2 + 2F_c^2)/3 \\ (\Delta/\sigma)_{\rm max} < 0.001 \\ \Delta\rho_{\rm max} = 0.97 \ {\rm e} \ {\rm \AA}^{-3} \\ \Delta\rho_{\rm min} = -0.94 \ {\rm e} \ {\rm \AA}^{-3} \end{split}$$

For compounds (I) and (II), data collection and cell refinement: *SMART* (Bruker, 1998); data reduction: *SHELXTL* (Sheldrick, 1998). For compound (III), data collection and cell refinement: *P*3 (Siemens, 1991); data reduction: *XDISK* (Siemens, 1991). For all compounds, program(s) used to solve and refine structure, and prepare material for publication: *SHELXTL*.

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